

# **Notice of References Cited**

Application/Control No.  
**10/034,338**

Applicant(s)/Patent Under Reexam  
**Wayne A. Morgan et al.**

Examiner  
**T. R. Sundaram**

Art Unit  
**2858**

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	3,716,059 /	2/1973	Welborn et al.	607	4
B	3,728,622 /	4/1973	Williams	324	71.1
C	3,992,665 /	11/1976	Preikschat	324	666
D	4,333,377 /	6/1982	Niezgoda et al.	84	627
E	4,533,986 /	8/1985	Jones	363	7
F	4,816,713 /	3/1989	Change, Jr.	310	319
G	5,040,533 /	8/1991	Fearnot	128-	419
H	5,394,095 /	2/1995	Kespohl	324	674
I	5,056,421 /	9/1996	Prutchi et al.	607	36
J	5,999,848 /	12/1999	Gord et al.	607	2
K	6,387,048 /	5/2002	Schulman et al.	600	300
L					
M					

## **FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N						
O						
P						
Q						
R						
S						
T						

## **NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
U	
V	
W	
X	

\* A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(e).

<sup>1</sup> Dates in MM-YYYY format are publication dates.

<sup>2</sup> Classifications may be U.S. or foreign.